

Notice of References Cited

Application/Control No.

10/519,846

Applicant(s)/Patent Under
Reexamination
KIM ET AL.

Examiner

DARREN B. SCHWARTZ

Art Unit

4193

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0114466 A1	08-2002	Tanaka et al.	380/232
*	B	US-2002/0184515 A1	12-2002	Oho et al.	713/193
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

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